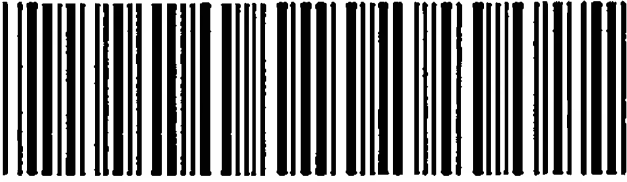


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/645,352	RYPAN, ZENON	
	Examiner	Art Unit	
	Philip H. Leung	3742	

SEARCHED			
Class	Subclass	Date	Examiner
219	756-757 745-746 754, 680	6/10/2005	<i>pl</i> P.L.
312	236		
126	37R		
D7	351		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST searched Inventorship checked	6/10/2005	<i>pl</i> P.L.